## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination YOKOUCHI, HIROSHI Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,937,415	08-1999	Sheffield et al.	707/204
*	В	US-5,873,074	02-1999	Kashyap et al.	707/2
*	С	US-6,745,209	06-2004	Holenstein et al.	707/203
*	D	US-6,112,209	08-2000	Gusack, Mark David	707/101
*	Е	US-5,884,324	03-1999	Cheng et al.	707/201
*	F	US-5,333,265	07-1994	Orimo et al.	709/201
*	G	US-5,757,669	05-1998	Christie et al.	709/205
*	Н	US-5,261,092	11-1993	McLaughlin et al.	713/375
*	1	US-5,870,765	02-1999	Bauer et al.	707/203
*	J	US-5,870,761	02-1999	Demers et al.	707/201
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO9908209	02-1999	PCT	Cochinwala,Munir et al.	17/30
	0	EP0445823	03-1991	European	Tsuruta,Setsuo et al.	9/44
	Р	EP0745238	02-1995	European	Hart,Keith	1/00
	α					
	R					
	S					•
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Williamson,DA, "database replication in a high up-time environment", proceedings, IEEE aerospace applications conference, 1996, vol 3, pp337-346				
	V	Matthias Wiesmann, et al. "understanding replication in databaes and distributed systems", , 2000				
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.